

Issue Classification		Application/Control No. 10/621,562	Applicant(s)/Patent under Reexamination YAMASHITA ET AL.
		Examiner Nhan T. Tran	Art Unit 2622

ISSUE CLASSIFICATION									
ORIGINAL				INTERNATIONAL CLASSIFICATION					
CLASS		SUBCLASS		CLAIMED			NON-CLAIMED		
348		364		H	04	N	5 /238	/	
CROSS REFERENCES									
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			H	04	N	5 /235	/	
348	229.1	315	275	302	H	04	N	5 /335	/
257	291				H	04	N	3 /14	/
250	208.1				H	01	L	31 /062	/
					H	01	L	27 /00	/
								/	/
<i>Nhan Tran</i> (Assistant Examiner) (Date)	<i>David Ometz</i> DAVID OMETZ SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date)							Total Claims Allowed: 8	
(Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. FIG. 2

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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9		39		69		99	
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30		60		90		120	